TL494

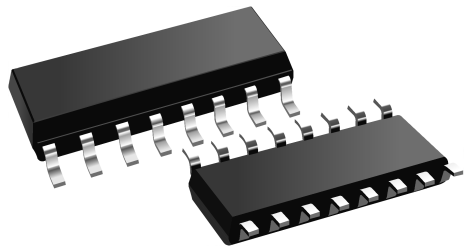
Switch Mode Power Supply Controller

Description

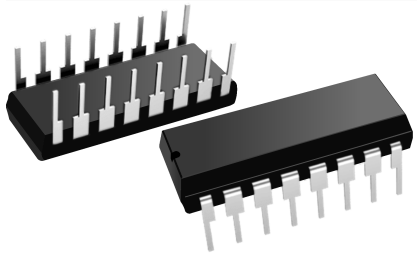
The TL494 is used for the control circuit of the PWM switching regulator, The TL494 consists of 5V reference voltage circuit, two error amplifiers, flip flop, an output control circuit, a PWM comparator, a dead time comparator and an oscillator. This device can be operated in the switching frequency of 1 KHz to 300 KHz.

Features

- Internal regulator provides a stable 5V reference supply trimmed to 5%
- Uncommitted output TR for 200mA sink or source current
- Output control for push-pull or single-ended operation
- Variable duty cycle by deadtime control (pin 4)Complete PWM control circuit
- On-chip oscillator with master or slave operation
- Internal circuit prohibits double pul se at either output



(SOP–16)



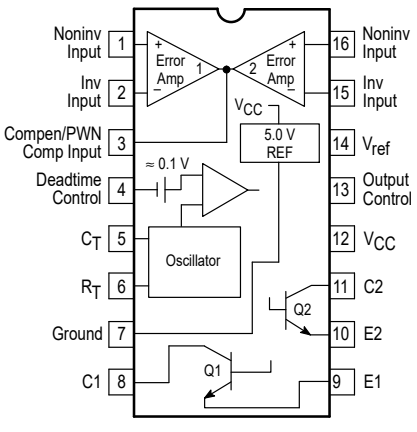
(DIP–16)

MAXIMUM RATINGS (Full operating ambient temperature range applies, unless otherwise noted.)

Rating	Symbol	TL494C	TL494I	Unit
Power Supply Voltage	V_{CC}	42		V
Collector Output Voltage	V_{C1}, V_{C2}	42		V
Collector Output Current (Each transistor) (Note 1)	I_{C1}, I_{C2}	500		mA
Amplifier Input Voltage Range	V_{IR}	–0.3 to +42		V
Power Dissipation @ $T_A \le 45°C$	P_D	1000		mW
Thermal Resistance, Junction–to–Ambient	$R_{\theta JA}$	80		°C/W
Operating Junction Temperature	T_J	125		°C
Storage Temperature Range	T_{stg}	–55 to +125		°C
Operating Ambient Temperature Range TL494C TL494I	T_A	0 to +70 –25 to +85		°C
Derating Ambient Temperature	T_A	45		°C

NOTE: Maximum thermal limits must be observed.

PIN CONNECTIONS



(Top View)

RECOMMENDED OPERATING CONDITIONS

Characteristics	Symbol	Min	Typ	Max	Unit
Power Supply Voltage	V_{CC}	7.0	15	40	V
Collector Output Voltage	V_{C1}, V_{C2}	–	30	40	V
Collector Output Current (Each transistor)	I_{C1}, I_{C2}	–	–	200	mA
Amplified Input Voltage	V_{in}	–0.3	–	V_{CC} – 2.0	V
Current Into Feedback Terminal	I_{fb}	–	–	0.3	mA
Reference Output Current	I_{ref}	–	–	10	mA
Timing Resistor	R_T	1.8	30	500	kΩ
Timing Capacitor	C_T	0.0047	0.001	10	μF
Oscillator Frequency	f_{osc}	1.0	40	200	kHz

ELECTRICAL CHARACTERISTICS (V_{CC} = 15 V, C_T = 0.01 μF, R_T = 12 kΩ, unless otherwise noted.)

For typical values T_A = 25°C, for min/max values T_A is the operating ambient temperature range that applies, unless otherwise noted.

Characteristics	Symbol	Min	Typ	Max	Unit
REFERENCE SECTION					
Reference Voltage (I_O = 1.0 mA)	V_{ref}	4.75	5.0	5.25	V
Line Regulation (V_{CC} = 7.0 V to 40 V)	Reg_{line}	–	2.0	25	mV
Load Regulation (I_O = 1.0 mA to 10 mA)	Reg_{load}	–	3.0	15	mV
Short Circuit Output Current (V_{ref} = 0 V)	I_{SC}	15	35	75	mA
OUTPUT SECTION					
Collector Off–State Current (V_{CC} = 40 V, V_{CE} = 40 V)	$I_{C(off)}$	–	2.0	100	μA
Emitter Off–State Current V_{CC} = 40 V, V_C = 40 V, V_E = 0 V)	$I_{E(off)}$	–	–	–100	μA
Collector–Emitter Saturation Voltage (Note 2)					V
Common–Emitter (V_E = 0 V, I_C = 200 mA)	$V_{sat(C)}$	–	1.1	1.3	
Emitter–Follower (V_C = 15 V, I_E = –200 mA)	$V_{sat(E)}$	–	1.5	2.5	
Output Control Pin Current					
Low State ($V_{OC} \le 0.4$ V)	I_{OCL}	–	10	–	μA
High State ($V_{OC} = V_{ref}$)	I_{OCH}	–	0.2	3.5	mA
Output Voltage Rise Time	t_r				ns
Common–Emitter (See Figure 12)		–	100	200	
Emitter–Follower (See Figure 13)		–	100	200	
Output Voltage Fall Time	t_f				ns
Common–Emitter (See Figure 12)		–	25	100	
Emitter–Follower (See Figure 13)		–	40	100	

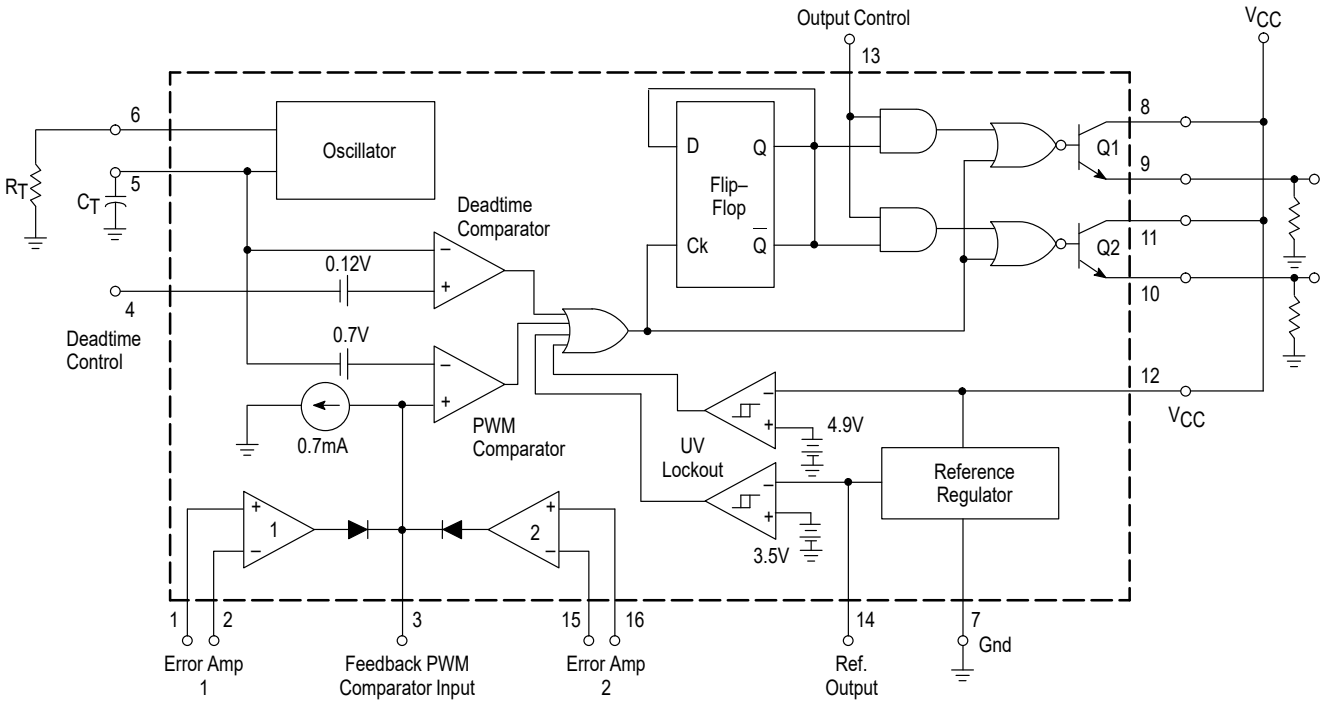
NOTE: 2. Low duty cycle pulse techniques are used during test to maintain junction temperature as close to ambient temperature as possible.

ELECTRICAL CHARACTERISTICS (V_{CC} = 15 V, C_T = 0.01 µF, R_T = 12 kΩ, unless otherwise noted.)
For typical values T_A = 25°C, for min/max values T_A is the operating ambient temperature range that applies, unless otherwise noted.

Characteristics	Symbol	Min	Typ	Max	Unit
ERROR AMPLIFIER SECTION					
Input Offset Voltage ($V_{O\ (Pin\ 3)}$ = 2.5 V)	V_{IO}	–	2.0	10	mV
Input Offset Current ($V_{O\ (Pin\ 3)}$ = 2.5 V)	I_{IO}	–	5.0	250	nA
Input Bias Current ($V_{O\ (Pin\ 3)}$ = 2.5 V)	I_{IB}	–	–0.1	–1.0	µA
Input Common Mode Voltage Range (V_{CC} = 40 V, T_A = 25°C)	V_{ICR}	–0.3 to V_{CC}–2.0			V
Open Loop Voltage Gain (ΔV_O = 3.0 V, V_O = 0.5 V to 3.5 V, R_L = 2.0 kΩ)	A_{VOL}	70	95	–	dB
Unity–Gain Crossover Frequency (V_O = 0.5 V to 3.5 V, R_L = 2.0 kΩ)	$f_{C–}$	–	350	–	kHz
Phase Margin at Unity–Gain (V_O = 0.5 V to 3.5 V, R_L = 2.0 kΩ)	ϕ_m	–	65	–	deg.
Common Mode Rejection Ratio (V_{CC} = 40 V)	CMRR	65	90	–	dB
Power Supply Rejection Ratio (ΔV_{CC} = 33 V, V_O = 2.5 V, R_L = 2.0 kΩ)	PSRR	–	100	–	dB
Output Sink Current ($V_{O\ (Pin\ 3)}$ = 0.7 V)	$I_{O–}$	0.3	0.7	–	mA
Output Source Current ($V_{O\ (Pin\ 3)}$ = 3.5 V)	I_{O+}	2.0	–4.0	–	mA
PWM COMPARATOR SECTION (Test Circuit Figure 11)					
Input Threshold Voltage (Zero Duty Cycle)	V_{TH}	–	2.5	4.5	V
Input Sink Current ($V_{(Pin\ 3)}$ = 0.7 V)	$I_{I–}$	0.3	0.7	–	mA
DEADTIME CONTROL SECTION (Test Circuit Figure 11)					
Input Bias Current (Pin 4) ($V_{Pin\ 4}$ = 0 V to 5.25 V)	$I_{IB\ (DT)}$	–	–2.0	–10	µA
Maximum Duty Cycle, Each Output, Push–Pull Mode ($V_{Pin\ 4}$ = 0 V, C_T = 0.01 µF, R_T = 12 kΩ) ($V_{Pin\ 4}$ = 0 V, C_T = 0.001 µF, R_T = 30 kΩ)	DC_{max}	 45 –	 48 45	 50 50	%
Input Threshold Voltage (Pin 4) (Zero Duty Cycle) (Maximum Duty Cycle)	V_{th}	 – 0	 2.8 –	 3.3 –	V
OSCILLATOR SECTION					
Frequency (C_T = 0.001 µF, R_T = 30 kΩ)	f_{osc}	–	40	–	kHz
Standard Deviation of Frequency* (C_T = 0.001 µF, R_T = 30 kΩ)	σf_{osc}	–	3.0	–	%
Frequency Change with Voltage (V_{CC} = 7.0 V to 40 V, T_A = 25°C)	Δf_{osc} (ΔV)	–	0.1	–	%
Frequency Change with Temperature ($\Delta T_A = T_{low}$ to T_{high}) (C_T = 0.01 µF, R_T = 12 kΩ)	Δf_{osc} (ΔT)	–	–	12	%
UNDERVOLTAGE LOCKOUT SECTION					
Turn–On Threshold (V_{CC} increasing, I_{ref} = 1.0 mA)	V_{th}	5.5	6.43	7.0	V
TOTAL DEVICE					
Standby Supply Current (Pin 6 at V_{ref}, All other inputs and outputs open) (V_{CC} = 15 V) (V_{CC} = 40 V)	I_{CC}	 – –	 5.5 7.0	 10 15	mA
Average Supply Current (C_T = 0.01 µF, R_T = 12 kΩ, $V_{(Pin\ 4)}$ = 2.0 V) (V_{CC} = 15 V) (See Figure 12)		–	7.0	–	mA

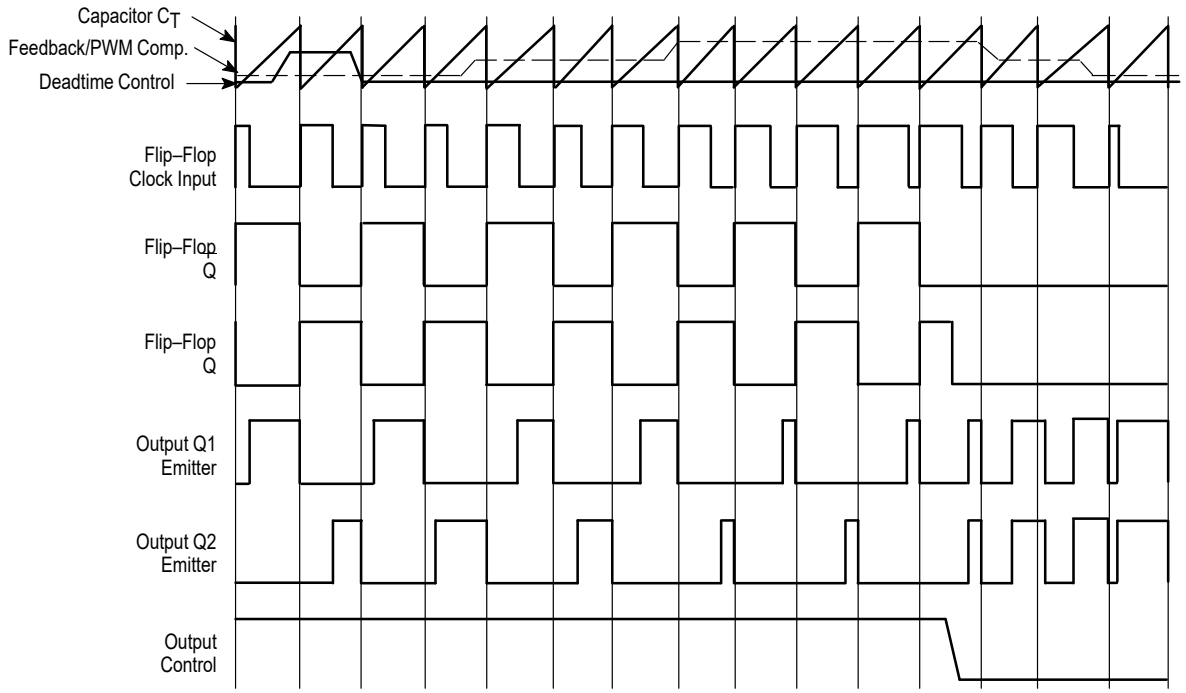
* Standard deviation is a measure of the statistical distribution about the mean as derived from the formula, $\sigma \sqrt{\frac{\sum_{n=1}^{N} (X_n - \bar{X})^2}{N-1}}$

Figure 1. Representative Block Diagram



This device contains 46 active transistors.

Figure 2. Timing Diagram



Description

The TL494 is a fixed–frequency pulse width modulation control circuit, incorporating the primary building blocks required for the control of a switching power supply. (See Figure 1.) An internal–linear sawtooth oscillator is frequency–programmable by two external components, R_T and C_T. The approximate oscillator frequency is determined by:

$$f_{osc} \approx \frac{1.1}{R_T \bullet C_T}$$

For more information refer to Figure 3.

Output pulse width modulation is accomplished by comparison of the positive sawtooth waveform across capacitor C_T to either of two control signals. The NOR gates, which drive output transistors Q1 and Q2, are enabled only when the flip–flop clock–input line is in its low state. This happens only during that portion of time when the sawtooth voltage is greater than the control signals. Therefore, an increase in control–signal amplitude causes a corresponding linear decrease of output pulse width. (Refer to the Timing Diagram shown in Figure 2.)

The control signals are external inputs that can be fed into the deadtime control, the error amplifier inputs, or the feedback input. The deadtime control comparator has an effective 120 mV input offset which limits the minimum output deadtime to approximately the first 4% of the sawtooth–cycle time. This would result in a maximum duty cycle on a given output of 96% with the output control grounded, and 48% with it connected to the reference line. Additional deadtime may be imposed on the output by setting the deadtime–control input to a fixed voltage, ranging between 0 V to 3.3 V.

Functional Table

Input/Output Controls	Output Function	$\frac{f_{out}}{f_{osc}}$ =
Grounded	Single–ended PWM @ Q1 and Q2	1.0
@ V_{ref}	Push–pull Operation	0.5

The pulse width modulator comparator provides a means for the error amplifiers to adjust the output pulse width from the maximum percent on–time, established by the deadtime control input, down to zero, as the voltage at the feedback pin varies from 0.5 V to 3.5 V. Both error amplifiers have a common mode input range from –0.3 V to (V_{CC} – 2V), and may be used to sense power–supply output voltage and current. The error–amplifier outputs are active high and are ORed together at the noninverting input of the pulse–width modulator comparator. With this configuration, the amplifier that demands minimum output on time, dominates control of the loop.

When capacitor C_T is discharged, a positive pulse is generated on the output of the deadtime comparator, which clocks the pulse–steering flip–flop and inhibits the output transistors, Q1 and Q2. With the output–control connected to the reference line, the pulse–steering flip–flop directs the modulated pulses to each of the two output transistors alternately for push–pull operation. The output frequency is equal to half that of the oscillator. Output drive can also be taken from Q1 or Q2, when single–ended operation with a maximum on–time of less than 50% is required. This is desirable when the output transformer has a ringback winding with a catch diode used for snubbing. When higher output–drive currents are required for single–ended operation, Q1 and Q2 may be connected in parallel, and the output–mode pin must be tied to ground to disable the flip–flop. The output frequency will now be equal to that of the oscillator.

The TL494 has an internal 5.0 V reference capable of sourcing up to 10 mA of load current for external bias circuits. The reference has an internal accuracy of ±5.0% with a typical thermal drift of less than 50 mV over an operating temperature range of 0° to 70°C.

Figure 3. Oscillator Frequency versus Timing Resistance

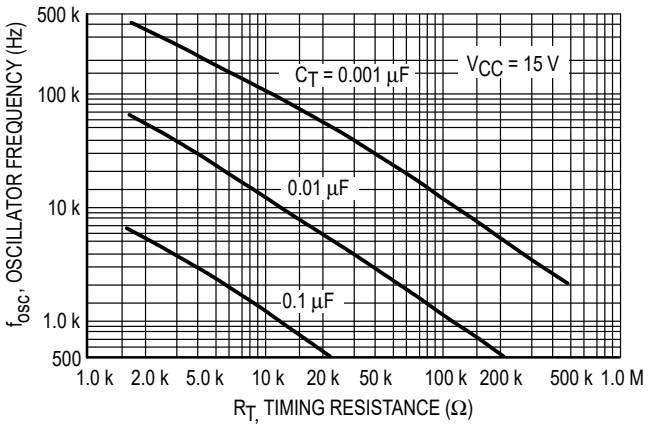


Figure 4. Open Loop Voltage Gain and Phase versus Frequency

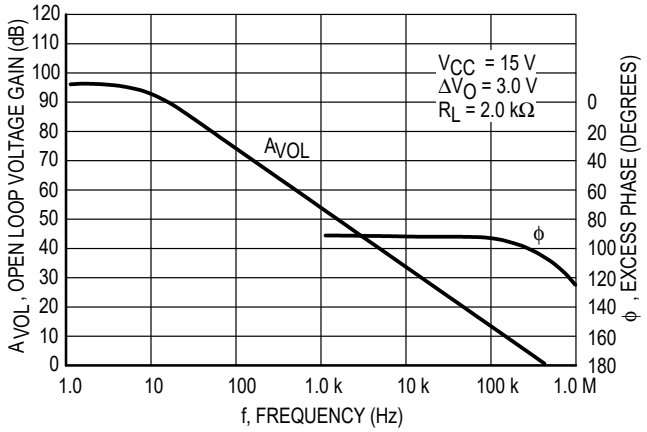


Figure 5. Percent Deadtime versus Oscillator Frequency

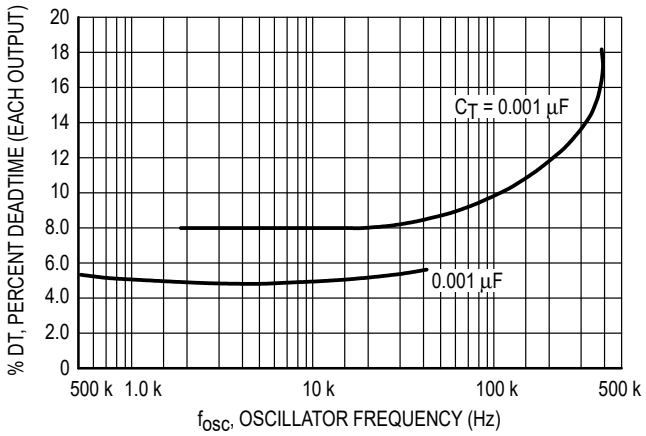


Figure 6. Percent Duty Cycle versus Deadtime Control Voltage

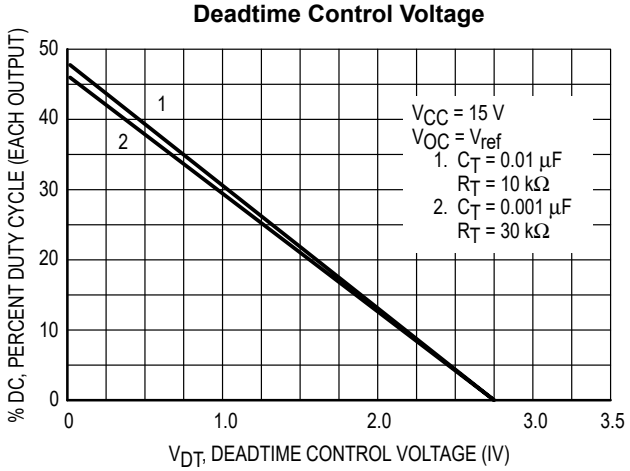


Figure 7. Emitter–Follower Configuration Output Saturation Voltage versus Emitter Current

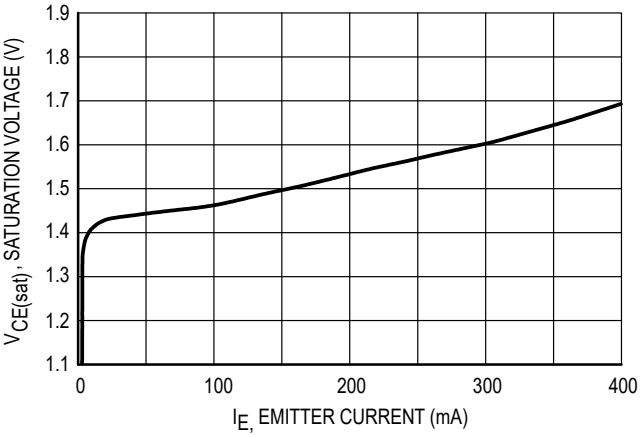


Figure 8. Common–Emitter Configuration Output Saturation Voltage versus Collector Current

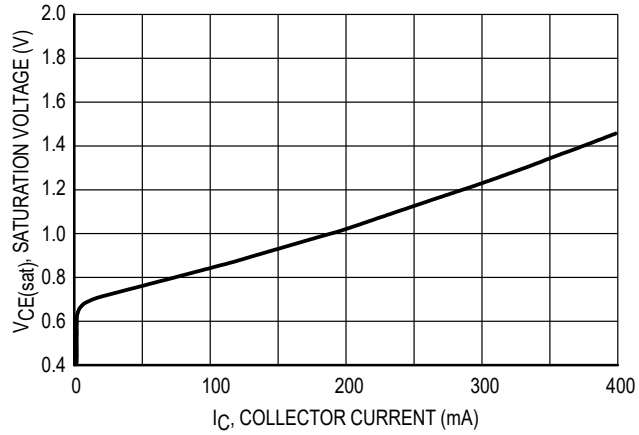


Figure 9. Standby Supply Current versus Supply Voltage

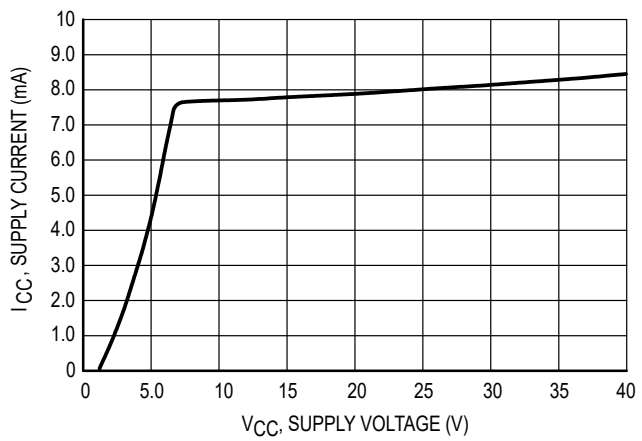


Figure 10. Error–Amplifier Characteristics

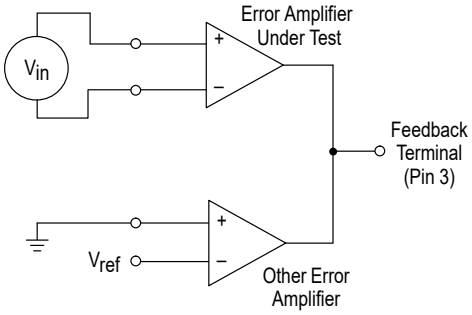


Figure 11. Deadtime and Feedback Control Circuit

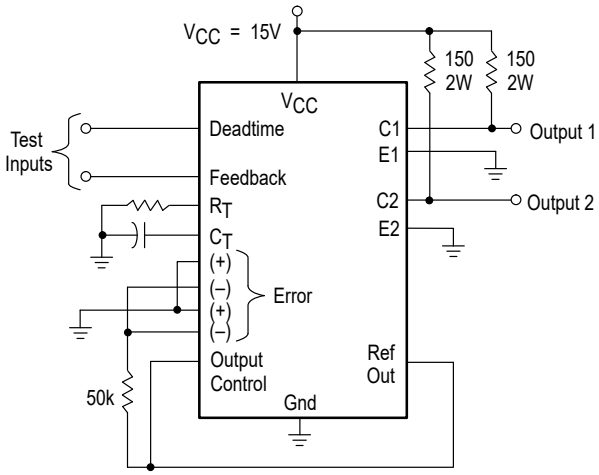


Figure 12. Common–Emitter Configuration Test Circuit and Waveform

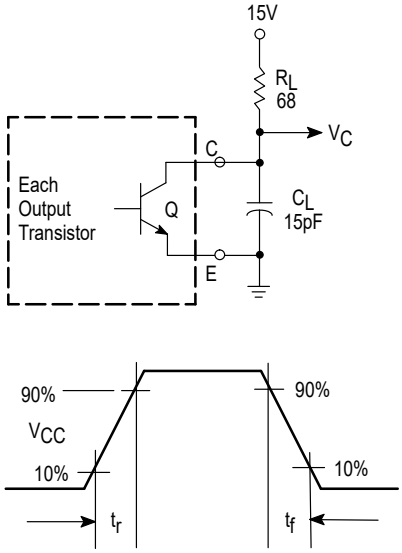
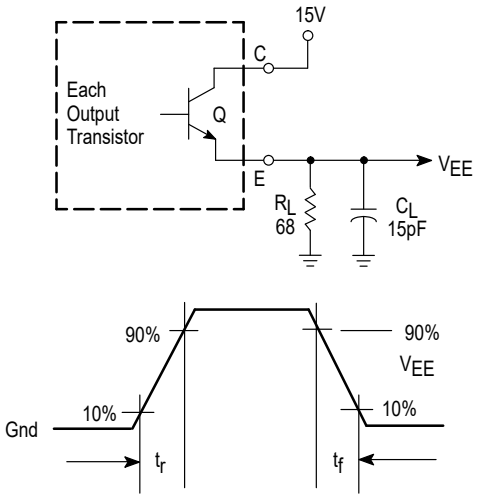


Figure 13. Emitter–Follower Configuration Test Circuit and Waveform



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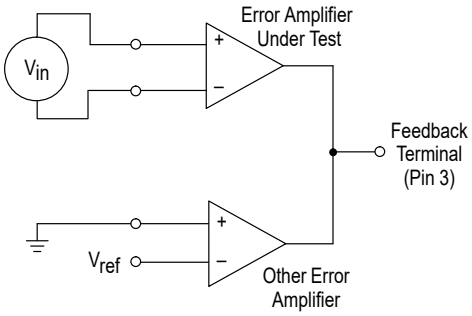

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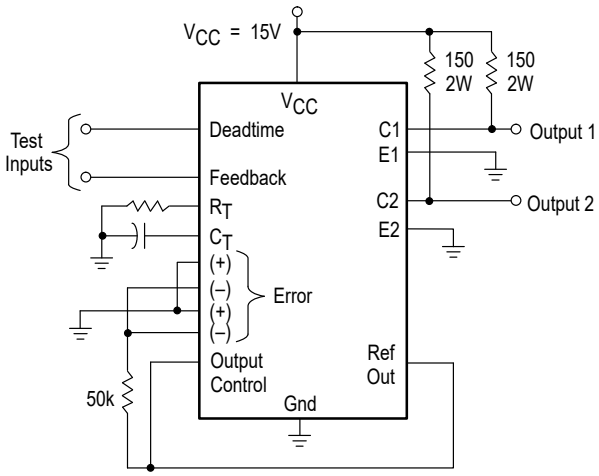


Figure 12. Common–Emitter Configuration Test Circuit and Waveform

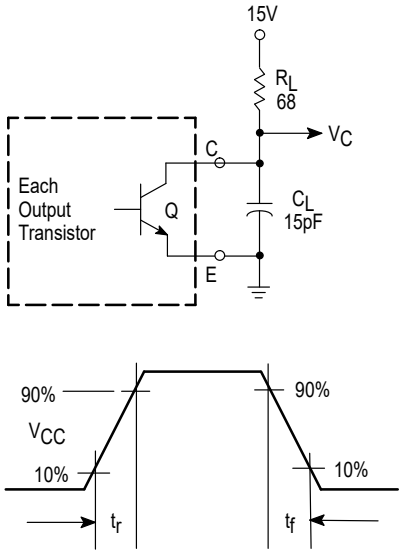


Figure 13. Emitter–Follower Configuration Test Circuit and Waveform

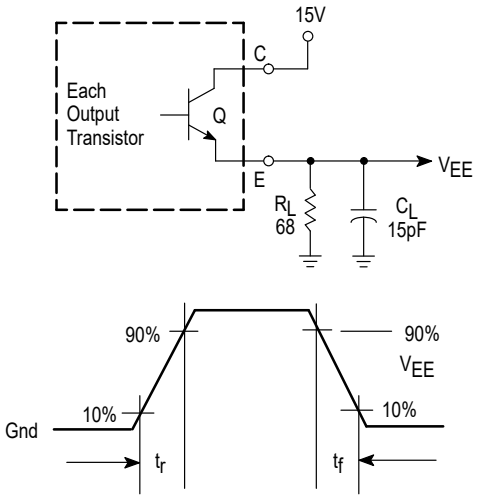


Figure 14. Error–Amplifier Sensing Techniques

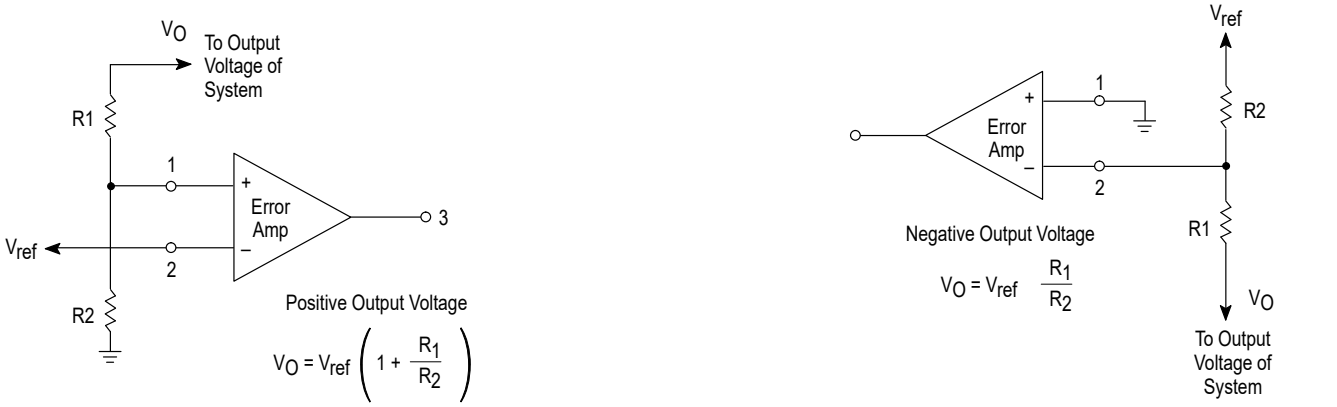


Figure 15. Deadtime Control Circuit

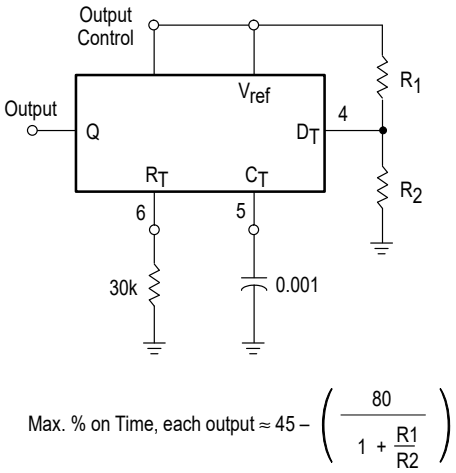


Figure 16. Soft–Start Circuit

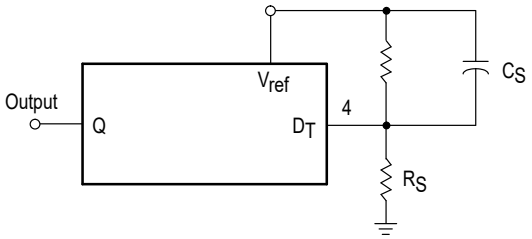


Figure 17. Output Connections for Single–Ended and Push–Pull Configurations

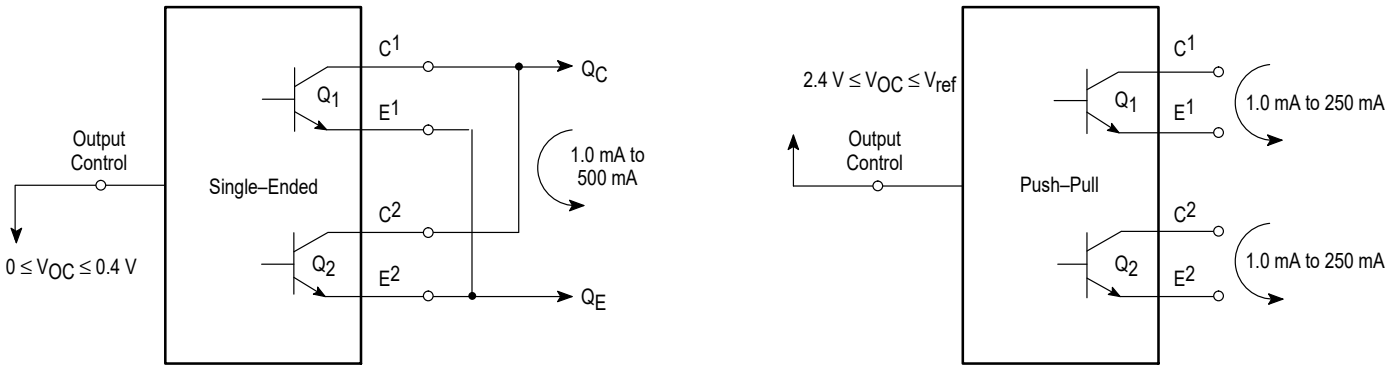


Figure 18. Slaving Two or More Control Circuits

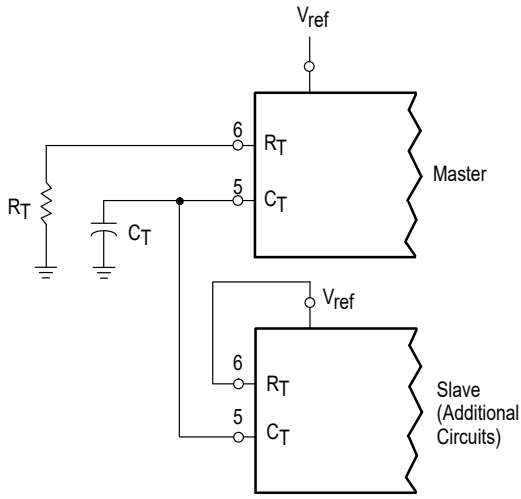


Figure 19. Operation with V_{in} > 40 V Using External Zener

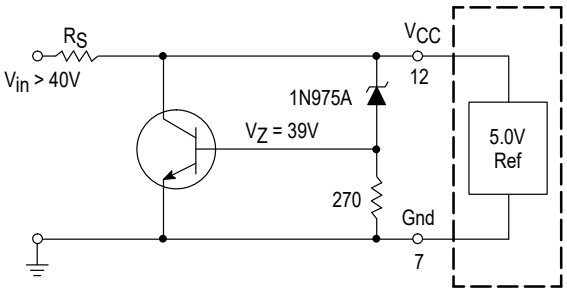
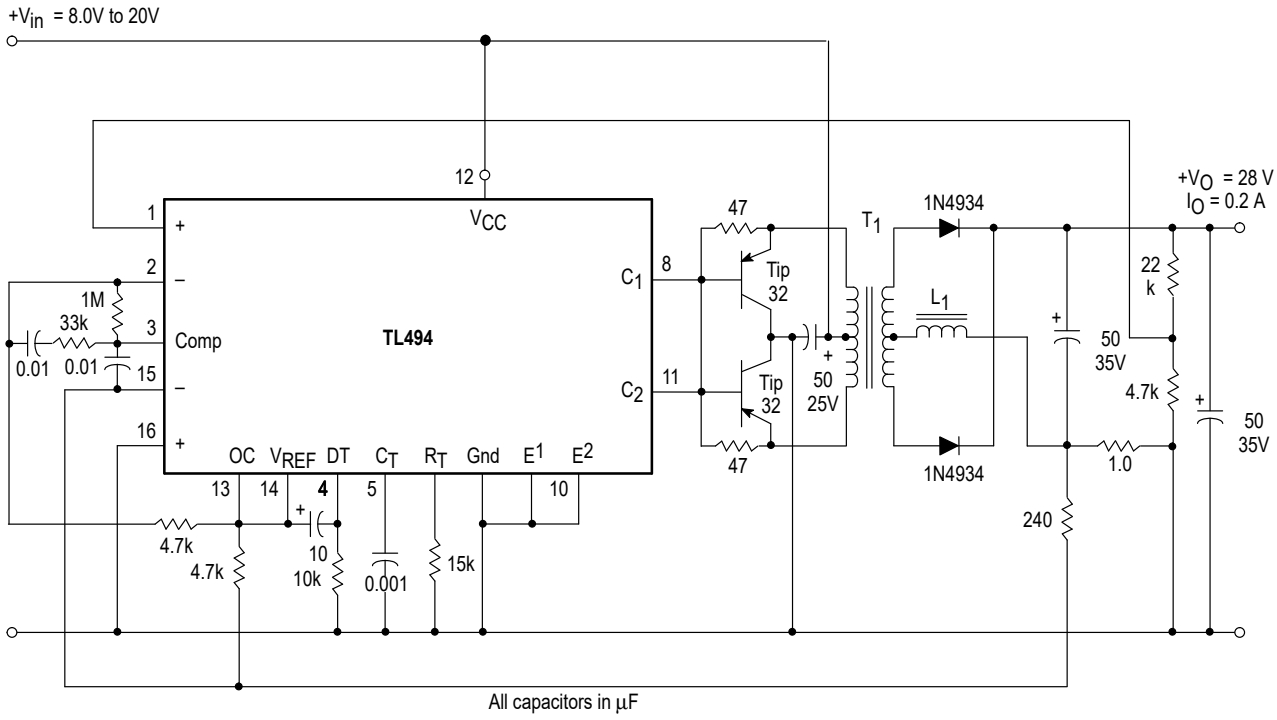


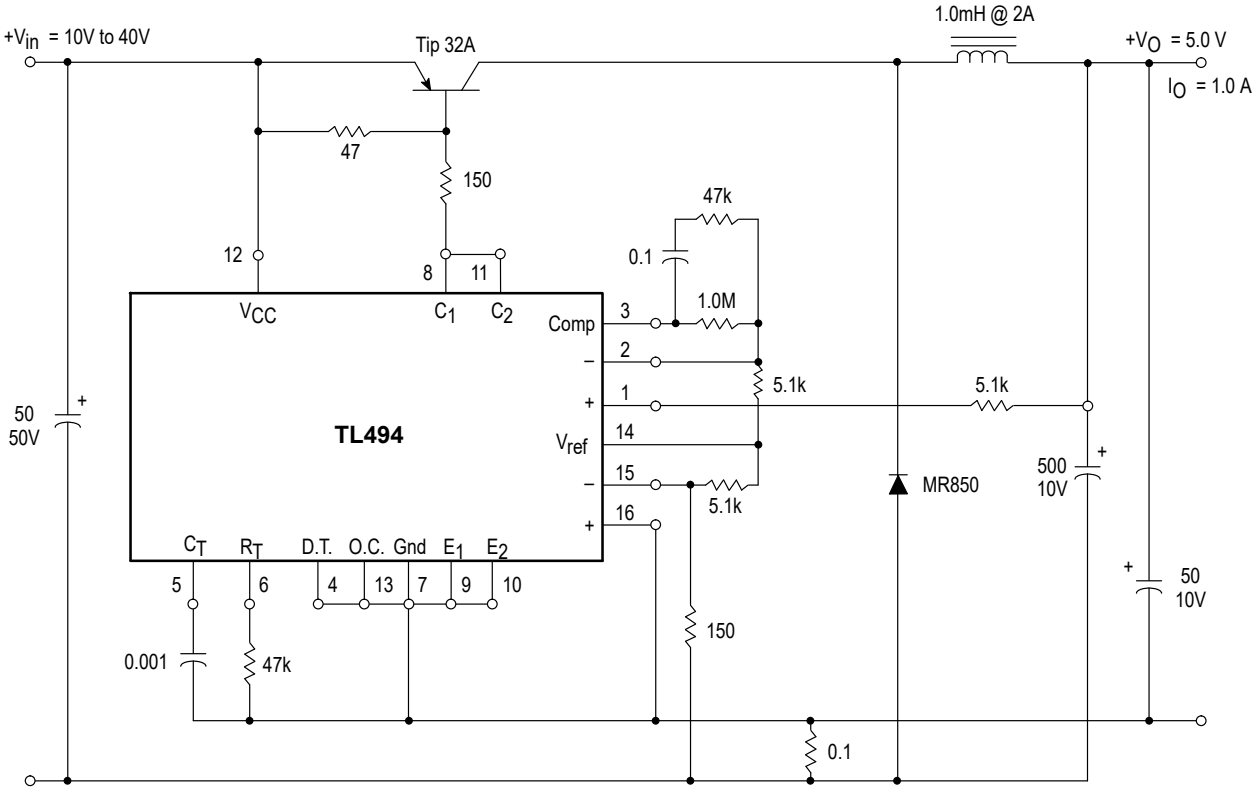
Figure 20. Pulse Width Modulated Push–Pull Converter



Test	Conditions	Results
Line Regulation	V_{in} = 10 V to 40 V	14 mV 0.28%
Load Regulation	V_{in} = 28 V, I_O = 1.0 mA to 1.0 A	3.0 mV 0.06%
Output Ripple	V_{in} = 28 V, I_O = 1.0 A	65 mV pp P.A.R.D.
Short Circuit Current	V_{in} = 28 V, R_L = 0.1 Ω	1.6 A
Efficiency	V_{in} = 28 V, I_O = 1.0 A	71%

L1 – 3.5 mH @ 0.3 A
T1 – Primary: 20T C.T. #28 AWG
Secondary: 12OT C.T. #36 AWG
Core: Ferroxcube 1408P–L00–3CB

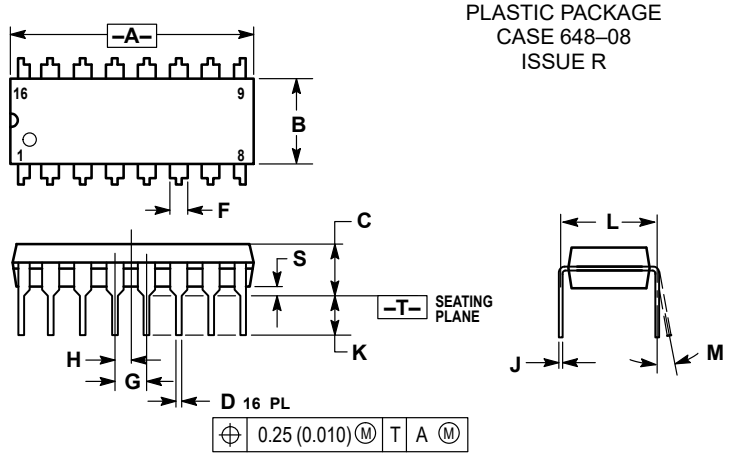
Figure 21. Pulse Width Modulated Step–Down Converter



Test	Conditions	Results
Line Regulation	V_{in} = 8.0 V to 40 V	3.0 mV 0.01%
Load Regulation	V_{in} = 12.6 V, I_O = 0.2 mA to 200 mA	5.0 mV 0.02%
Output Ripple	V_{in} = 12.6 V, I_O = 200 mA	40 mV pp P.A.R.D.
Short Circuit Current	V_{in} = 12.6 V, R_L = 0.1 Ω	250 mA
Efficiency	V_{in} = 12.6 V, I_O = 200 mA	72%

OUTLINE DIMENSIONS

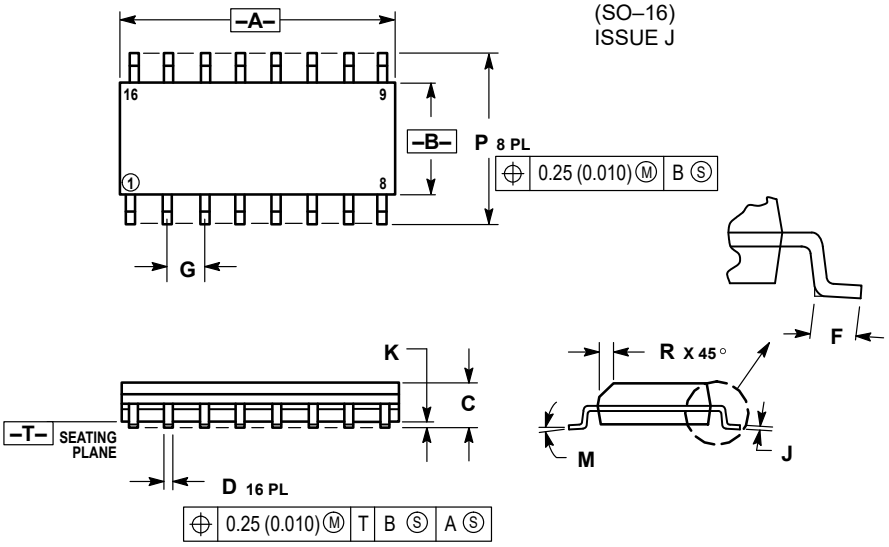
N SUFFIX
PLASTIC PACKAGE
CASE 648–08
ISSUE R



NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL.
4. DIMENSION B DOES NOT INCLUDE MOLD FLASH.
5. ROUNDED CORNERS OPTIONAL.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
A	0.740	0.770	18.80	19.55
B	0.250	0.270	6.35	6.85
C	0.145	0.175	3.69	4.44
D	0.015	0.021	0.39	0.53
F	0.040	0.70	1.02	1.77
G	0.100 BSC		2.54 BSC	
H	0.050 BSC		1.27 BSC	
J	0.008	0.015	0.21	0.38
K	0.110	0.130	2.80	3.30
L	0.295	0.305	7.50	7.74
M	0 °	10 °	0 °	10 °
S	0.020	0.040	0.51	1.01

D SUFFIX
PLASTIC PACKAGE
CASE 751B–05
(SO–16)
ISSUE J



NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION.
4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.

	MILLIMETERS		INCHES	
DIM	MIN	MAX	MIN	MAX
A	9.80	10.00	0.386	0.393
B	3.80	4.00	0.150	0.157
C	1.35	1.75	0.054	0.068
D	0.35	0.49	0.014	0.019
F	0.40	1.25	0.016	0.049
G	1.27 BSC		0.050 BSC	
J	0.19	0.25	0.008	0.009
K	0.10	0.25	0.004	0.009
M	0 °	7 °	0	7
P	5.80	6.20	0.229	0.244
R	0.25	0.50	0.010	0.019

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For additional information, please contact your local Sales Representative.

